

<b>Notice of References Cited</b>	Application/Control No. 10/733,771	Applicant(s)/Patent Under Reexamination VAN BEEK ET AL.	
	Examiner Kevin Gutierrez	Art Unit 2851	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,539,211 A	07-1996	Ohtoshi et al.	250/441.11
*	B	US-5,981,960 A	11-1999	Ooaeh et al.	250/492.2
*	C	US-5,466,942 A	11-1995	Sakai et al.	250/492.2
*	D	US-6,614,505 B2	09-2003	Koster et al.	355/30
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.